DESCRIPTION

The AG2113 is a high voltage, high speed power MOSFET and IGBT driver with independent high and low side referenced output channels based on P_SUB P_EPI process. Logic inputs are compatible with standard CMOS or LSTTL output, down to 3V logic. The output drivers feature a high pulse current buffer stage designed for minimum driver cross-conduction. Propagation delays are matched to simplify use in high frequency applications. The floating channel can be used to drive an N-channel power MOSFET or IGBT in the high side configuration which operates up to 600 V.

AG2113 is available in a SOP16 package.

ORDERING INFORMATION

| Package Type | Part Number | | |
|--------------------------------|-------------------------|-------------|--|
| SOP16 | MAG | AG2113M16R | |
| SPQ: 1,500pcs/Reel | M16 | AG2113M16VR | |
| Note | V: Halogen free Package | | |
| Note | R: Tape & Reel | | |
| AiT provides all RoHS products | | | |

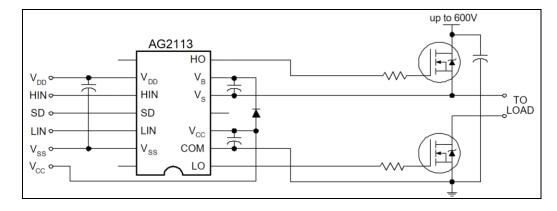
FEATURES

- Floating channel designed for bootstrap
 - -Fully operational to +600 V
 - -Tolerant to negative transient voltage dV/dt immune
- Gate drive supply range from 10 V to 20 V
- Undervoltage lockout (UVLO) for both channels
- Separate logic supply range from 5 to 20V
 - -Logic and power ground ±5V offset
- 3.3 V /5 V/15 V logic compatible
- 2.5A Output Current Capability
- Matched propagation delay for both channels
- Output in phase with inputs

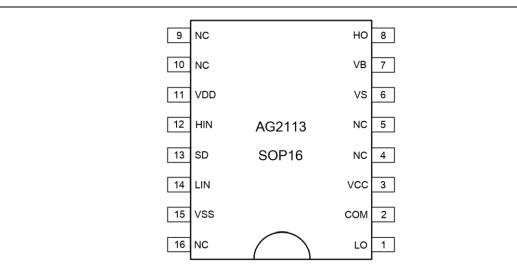
APPLICATION

- DC/DC Converter
- Power MOSFET or IGBT driver
- DC/AC Converter

TYPICAL APPLICATION



PIN DESCRIPTION



SOP16, M16 Top View

| Pin# | Symbol | Function |
|------|----------------|--|
| 1 | LO | Low side gate drive output, in phase with LIN |
| 2 | СОМ | Low side return |
| 3 | Vcc | Low side supply |
| 6 | Vs | High side floating supply return |
| 7 | V _B | High side floating supply |
| 8 | НО | High side gate drive output, in phase with HIN |
| 11 | V_{DD} | Logic supply |
| 12 | HIN | Logic input for high side gate driver output (HO) , in phase |
| 16 | SD | Logic input for shutdown |
| 14 | LIN | Logic input for low side gate driver output (LO), in phase |
| 15 | Vss | Logic ground |
| 16 | NC | Not Connected |

ABSOLUTE MAXIMUM RATINGS

| Parameter | Symbol | Min. | Max. | Units |
|--|-------------------|----------------------|-----------------------|-------|
| High side floating supply | V _B | -0.3 | 625 | V |
| High side floating supply return | Vs | V _B - 25 | V _B + 0.3 | |
| High side gate drive output | V _{HO} | Vs - 0.3 | V _B + 0.3 | |
| Low side supply | Vcc | -0.3 | 25 | |
| Low side gate drive output | V_{LO} | -0.3 | V _{CC} + 0.3 | |
| Logic supply | V_{DD} | -0.3 | V _{CC} + 0.3 | |
| Logic ground | Vss | V _{CC} -25 | Vcc + 0.3 | |
| Logic input | V _{IN} | V _{SS} -0.3 | V _{DD} + 0.3 | |
| Allowable Offset Supply Voltage Transient | dVs/dt | | 50 | V/ns |
| HBM Model | ESD | 2.5 | | kV |
| Machine Model | ESD | 200 | | V |
| Package Power Dissipation @ T _A ≤25°C (14 Lead DIP) | DD | | 1.6 | W |
| Package Power Dissipation @ T _A ≤25°C (16 Lead SOW) | PD | | 1.25 | |
| Thermal Resistance Junction to Ambient (14 Lead DIP) | Б | | 75 | °C /W |
| Thermal Resistance Junction to Ambient (16 Lead SOW) | R _{thJA} | | 100 | |
| Junction Temperature | TJ | | 150 | °C |
| Storage Temperature | Ts | -55 | 150 | |
| Lead Temperature (Soldering, 10 seconds) | TL | | 300 | |

Stress beyond above listed "Absolute Maximum Ratings" may lead permanent damage to the device. These are stress ratings only and operations of the device at these or any other conditions beyond those indicated in the operational sections of the specifications are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

RECOMMENDED OPERATING CONDITIONS

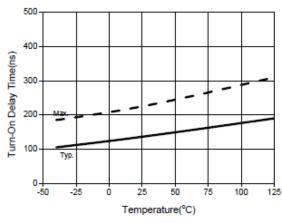
| Parameter | Symbol | Min. | Max. | Units |
|-------------------------------------|-----------------|--------------------|----------------|-------|
| High side floating supply | V _B | Vs + 10 | Vs + 20 | |
| High side floating supply return | Vs | COM - 8 | 600 | |
| High side gate drive output voltage | V _{HO} | Vs | V _B | |
| Low side supply | Vcc | 10 | 20 | V |
| Low side gate drive output voltage | V _{LO} | 0 | Vcc | V |
| Logic supply | V _{DD} | V _{SS} +3 | Vss+20 | |
| Logic ground | Vss | -5 | 5 | |
| Logic input voltage(HIN & LIN & SD) | Vin | 0 | V_{DD} | |
| Ambient temperature | TA | -40 | 125 | °C |

ELECTRICAL CHARACTERISTICS

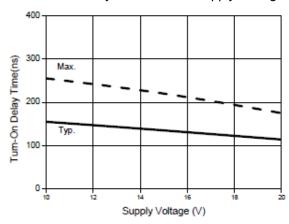
| Parameter | Symbol | Conditions | Min | Тур. | Max | Units |
|---|--------------------------|----------------------------------|----------|------------|------|-------|
| Dynamic | | | | | | |
| V_{BIAS} (V _{CC} , V_{BS}) = 15V, C_L = 1000pF, T_A = 25°C, unless otherwise specified. | | | | | | |
| Turn-On Propagation Delay | ton | | 1 | 135 | 220 | |
| Turn-Off Propagation Delay | t _{off} | | 1 | 130 | 220 | |
| Shutdown Propagation Delay | t_{sd} | | - | 135 | 220 | |
| Delay Matching | MT | | - | - | 30 | ns |
| Turn-On Rise Time | t _r | | - | 20 | 30 | |
| Turn-Off Fall Time | t _f | | - | 15 | 25 | |
| Static | | | | | | |
| V_{BIAS} (V _{CC} , V _{BS} , V _{DD}) = 15V, C _L = 1000pF, | Γ _A = 25°C, \ | V _{SS} =COM, unless oth | erwise s | specified. | | |
| Logic "1"(IN) Input Voltage | VIH | | 9.5 | 1 | - | |
| Logic "0" (IN) Input Voltage | V_{IL} | | - | - | 5 | V |
| High Level Output Voltage, V _{BIAS} - V _O | Vон | | - | - | 1.4 | |
| Low Level Output Voltage, Vo | V_{OL} | | - | - | 0.15 | |
| Quiescent V _{DD} Supply Current | I _{QDD} | | - | - | 30 | |
| Quiescent V _{CC} Supply Current | I _{QCC} | | - | 120 | 240 | |
| Quiescent V _B Supply Current | I _{QBS} | | - | 75 | 150 | ^ |
| Leakage Current From Vs(600V) to GND | I _{LK} | | - | - | 10 | μA |
| Logic "1" Input Bias Current | I _{IN} + | | - | 20 | 40 | |
| Logic "0" Input Bias Current | I _{IN} - | | - | - | 5 | |
| V 0 1 10 4 0 T1 1 1 1 | V _{BSU} + | | 7.5 | 8.4 | 9.7 | |
| V _{BS} Supply UVLO Threshold | V _{BSU} - | | 7 | 8 | 9.4 | |
| V _{CC} Supply UVLO Threshold | V _{CCU} + | | 7.5 | 8.4 | 9.6 | V |
| | Vccu- | | 7 | 8 | 9.4 | |
| Output High Short Circuit Pulsed Current | l _O + | | - | 2.5 | - | |
| Output Low Short Circuit Pulsed Current | lo- | | - | 2.5 | - | Α |

TYPICAL PERFORMANCE CHARACTERISTICS

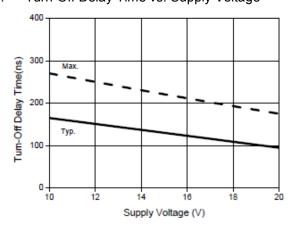
Turn-On Delay vs. Temperature 1.



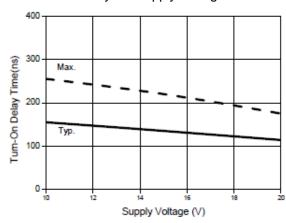
Turn-On Delay Time vs. VDD Supply Voltage 3.



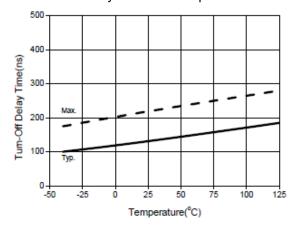
5. Turn-Off Delay Time vs. Supply Voltage



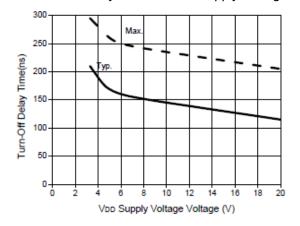
2. Turn-On Delay vs. Supply Voltage



Turn-Off Delay Time vs. Temperature 4.

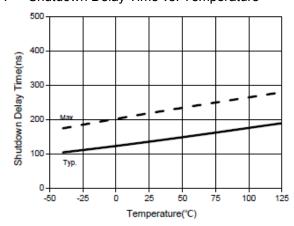


6. Turn-Off Delay Time vs. VDD Supply Voltage

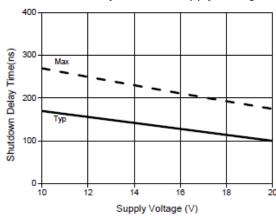




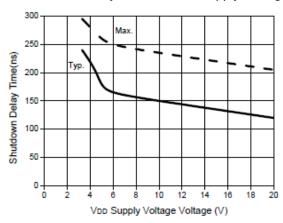
7. Shutdown Delay Time vs. Temperature



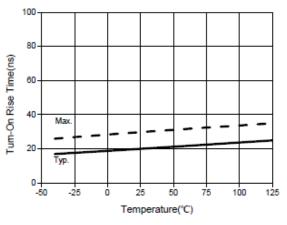
8. Shutdown Delay Time vs. Supply Voltage



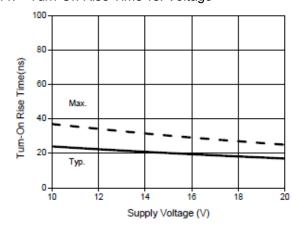
9. Shutdown Delay Time vs. V_{DD} Supply Voltage



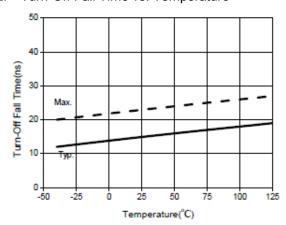
10. Turn-On Rise Time vs. Temperature



11. Turn-On Rise Time vs. Voltage

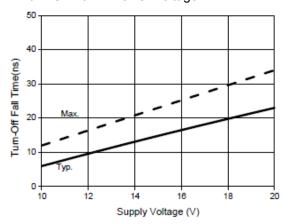


12. Turn-Off Fall Time vs. Temperature

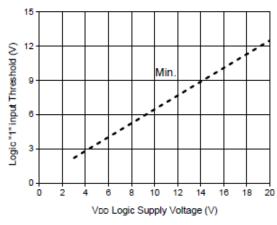




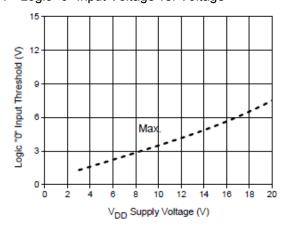
13. Turn-Off Fall Time vs. Voltage



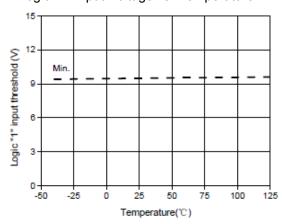
15. Logic "1" Input Voltage vs. Voltage



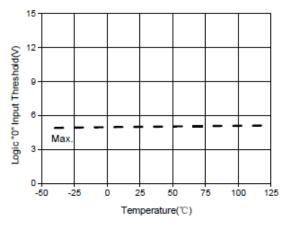
17. Logic "0" Input Voltage vs. Voltage



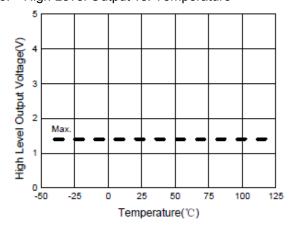
14. Logic "1" Input Voltage vs. Temperature



16. Logic "0" Input Voltage vs. Temperature

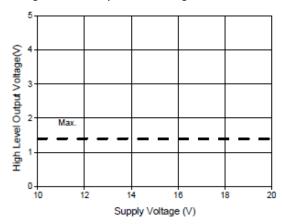


18. High Level Output vs. Temperature

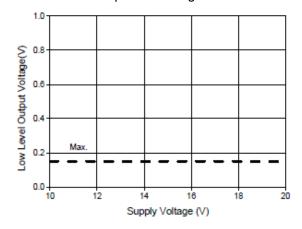




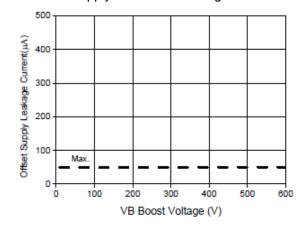
19. High Level Output vs. Voltage



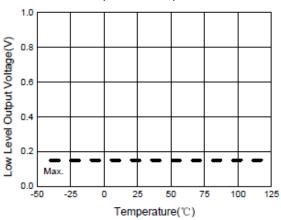
21. Low Level Output vs. Voltage



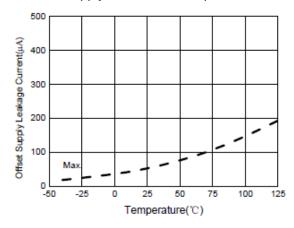
23. Offset Supply Current vs. Voltage



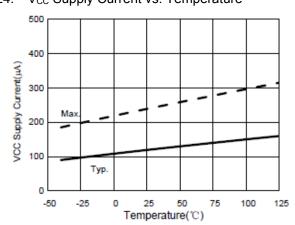
20. Low Level Output vs. Temperature



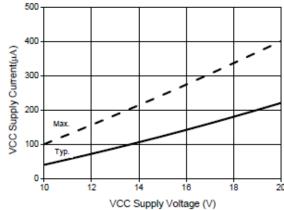
22. Offset Supply Current vs. Temperature



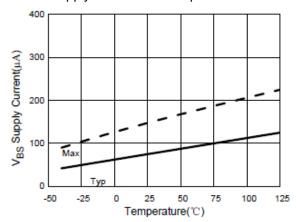
24. V_{CC} Supply Current vs. Temperature



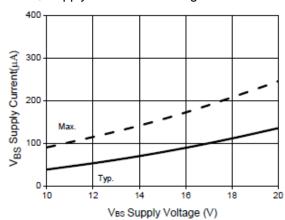
25. Vcc Supply Current vs. Voltage



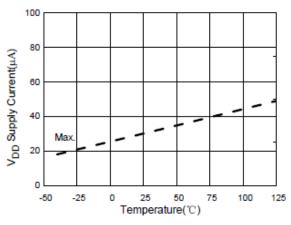
26. V_{BS} Supply Current vs. Temperature



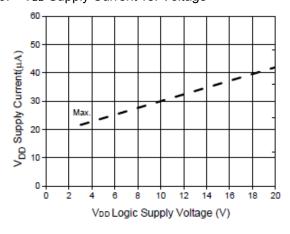
27. V_{BS} Supply Current vs. Voltage



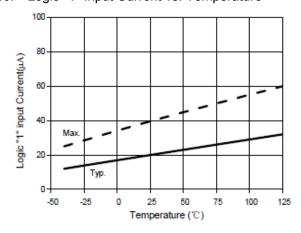
28. V_{DD} Supply Current vs. Temperature



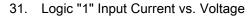
29. V_{DD} Supply Current vs. Voltage

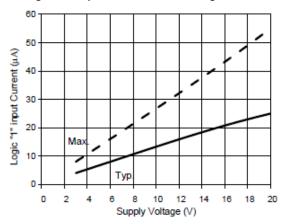


30. Logic "1" Input Current vs. Temperature

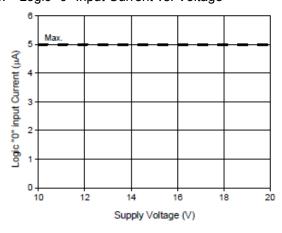




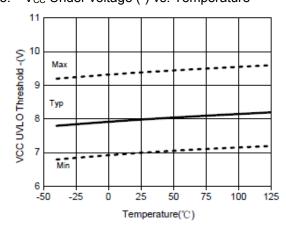




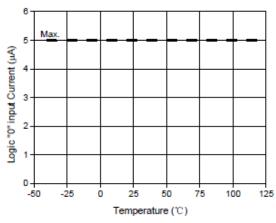
33. Logic "0" Input Current vs. Voltage



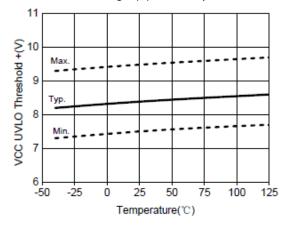
35. V_{CC} Under voltage (-) vs. Temperature



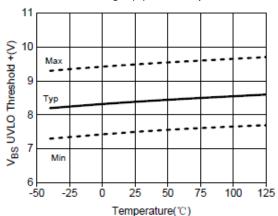
32. Logic "0" Input Current vs. Temperature



34. V_{CC} Under voltage (+) vs. Temperature

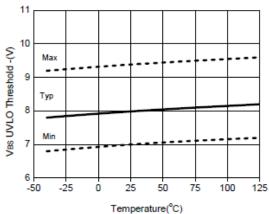


36. V_{BS} Under voltage (+) vs. Temperature

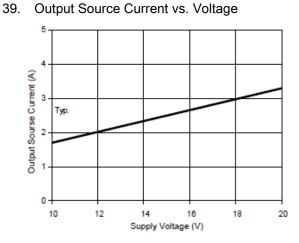




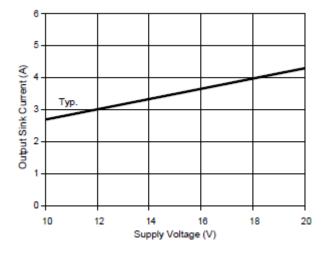
37. V_{BS} Under voltage (-) vs. Temperature



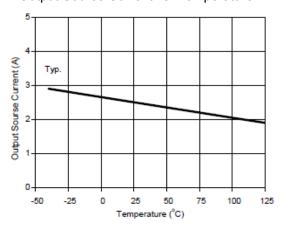
. . . .



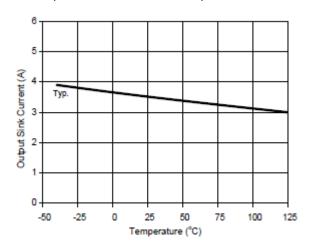
41. Output Sink Current vs. Voltage



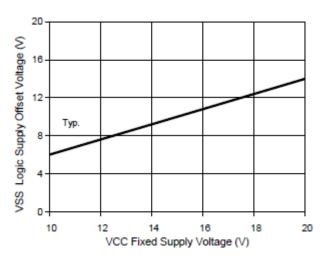
38. Output Source Current vs. Temperature



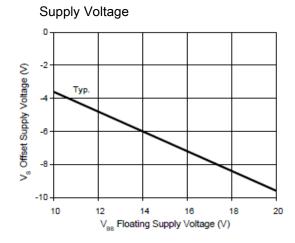
40. Output Sink Current vs. Temperature



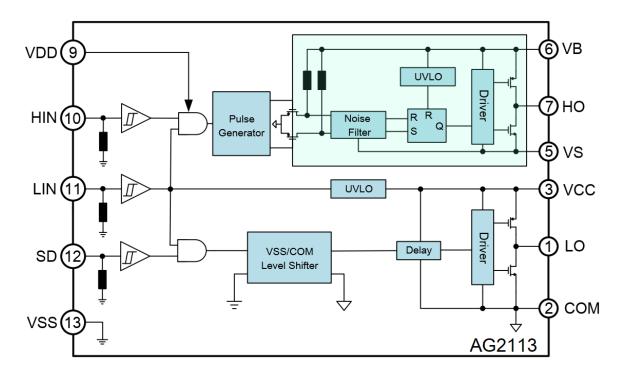
42. Maximum Vss Positive Offset vs. Vcc Supply Voltage



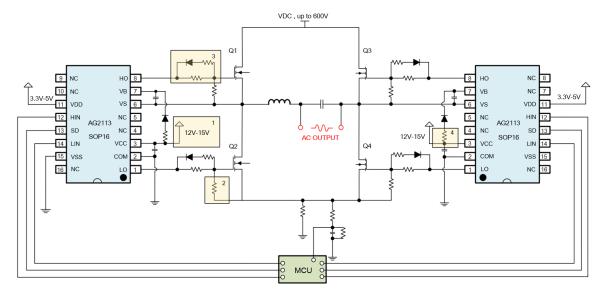
43. Maximum Vss Positive Offset vs. Vcc



BLOCK DIAGRAM



TYPICAL APPLICATION CIRCUIT



- 1. V_{CC} supply voltage, for IGBTs, should be 15V, for MOSFETs, should be 12V-15V.
- 2. Pull down resistor between Gate and Source of power device, the value is 10k ohms.
- 3. Driver circuit, turn on and turn off channel should be independently, the resistors value according to power device.
- 4. The resistor between $V_{\text{CC}} \, \text{and bootstrap diode, to avoid } V_{\text{BS}} \, \text{dv/dt.}$

Function Timing Diagram

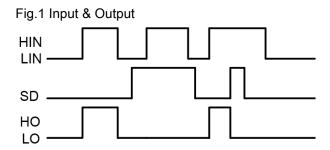
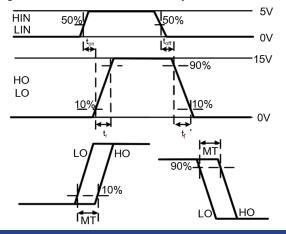


Fig.2 SD Delay Time

SD 50% 0V

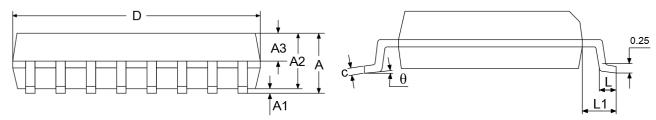
HO LO 0V

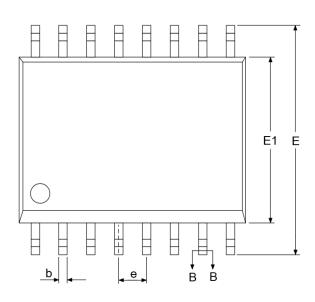
Fig.3 Turn on and Turn off Delay



PACKAGE INFORMATION

Dimension in SOP16 (Unit: mm)





| Symbol | Min. | Max. | |
|--------|----------|-------|--|
| Α | - | 2.65 | |
| A1 | 0.10 | 0.30 | |
| A2 | 2.25 | 2.35 | |
| A3 | 0.97 | 1.07 | |
| b | 0.35 | 0.44 | |
| b1 | 0.34 | 0.39 | |
| С | 0.25 | 0.31 | |
| c1 | 0.24 | 0.26 | |
| D | 10.10 | 10.50 | |
| Е | 10.26 | 10.60 | |
| E1 | 7.30 | 7.70 | |
| е | 1.27 BSC | | |
| L | 0.55 | 0.85 | |
| L1 | 1.4 BSC | | |
| θ | 0° | 8° | |

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